

Material Surface Inspection System

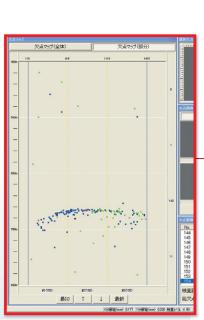
M-CAP Series

Perfectly captures defects on the surfaces of non-printed materials with high precision and sensitive mono-chrome cameras

Main Features

Defects Display

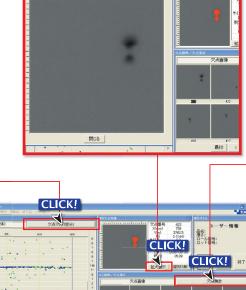
- Reasonable, high performance system
- Modular concept allows easy installation in production lines
- Special lighting system ensures 100% defect inspection
- Both reflection & back light modes can be used at the same time
- Able to distinguish subtle variations in grey scale
- Individual defects, roll defects, as well as selected defects can be output
- LAN cable network allows retrieval and analysis of data by different departments

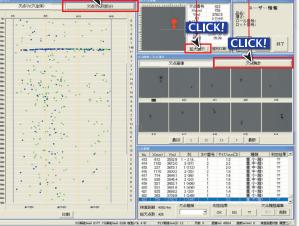


Defect Map of Selected Section



Enlargement of Single Defect





Defect Map in Roll Report



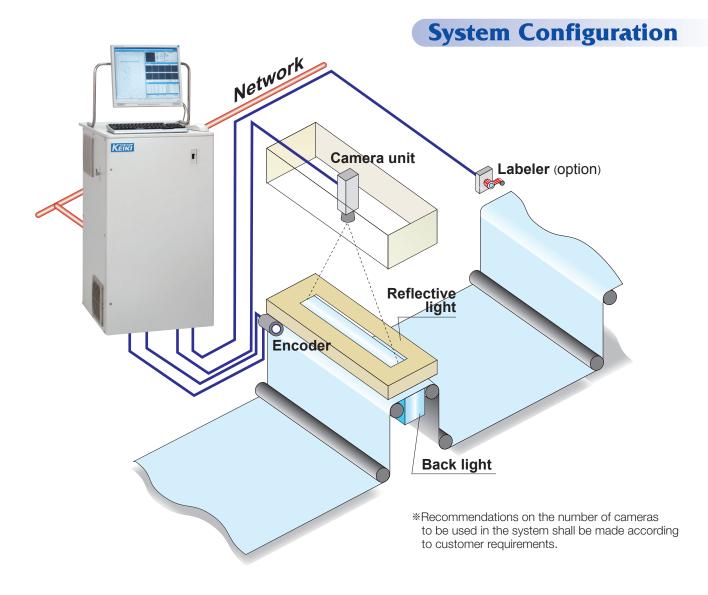
Tabular Display

Data History

		700~800m	800~900m	900~1000m	1000~1100m	1100~1200m	1200~1300m
	L	0	0	0	0	0	0
	М	5	0	2	0	2	2
	s	6	8	5	2	5	9
	Tot	11	8	7	2	7	11
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Data Can be exported to .csv file , MS-Excel can be used for statistical analysis

TOKYO KEIKI INC.



Applications

M-Cap can capture defects on non-printed film and sheets, nonwoven fabric, etc.M-Cap can be installed on plastic and sheet extruders.

Design and specifications are subject to change without prior notice.



CAUTION Thoroughly read the instruction manual before operating the equipment.

http://www.tokyo-keiki.co.jp/ips/

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